

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination LIM ET AL.	
		Examiner DAVID CZEKAJ	Art Unit 2621	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,143,434	11-2006	Paek et al.	725/142
*	B	US-6,728,314	04-2004	Kan et al.	375/240.12
*	C	US-6,577,679	06-2003	Apostolopoulos, John G.	375/240.12
*	D	US-6,404,814	06-2002	Apostolopoulos et al.	375/240.12
*	E	US-7,023,441	04-2006	Choi et al.	345/441
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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